



Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



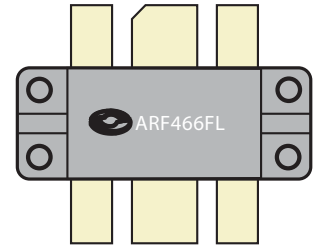
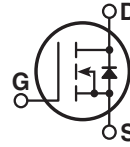
## Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China




**200V 300W 45MHz**

## RF POWER MOSFETs

### N-CHANNEL ENHANCEMENT MODE

The ARF466FL is a rugged high voltage RF power transistor designed for scientific, commercial, medical and industrial RF power amplifier applications up to 45 MHz. It has been optimized for both linear and high efficiency classes of operation.

- Specified 150 Volt, 40.68 MHz Characteristics:
  - Output Power = 300 Watts.
  - Gain = 16dB (Class AB)
  - Efficiency = 75% (Class C)
- Low Cost Flangeless RF Package.
- Low Vth thermal coefficient.
- Low Thermal Resistance.
- Optimized SOA for Superior Ruggedness.

#### Maximum Ratings

 All Ratings:  $T_c = 25^\circ\text{C}$  unless otherwise specified


| Symbol         | Parameter   | Ratings    | Unit             |
|----------------|---|------------|------------------|
| $V_{DSS}$      | Drain-Source Voltage                                | 1000       | V                |
| $V_{DGO}$      | Drain-Gate Voltage                                  | 1000       |                  |
| $I_D$          | Continuous Drain Current @ $T_c = 25^\circ\text{C}$ | 13         | A                |
| $V_{GS}$       | Gate-Source Voltage                                 | $\pm 30$   | V                |
| $P_D$          | Total Power Dissipation @ $T_c = 25^\circ\text{C}$  | 1153       | W                |
| $T_J, T_{STG}$ | Operating and Storage Junction Temperature Range    | -55 to 175 | $^\circ\text{C}$ |
| $T_L$          | Lead Temperature: 0.063" from Case for 10 Sec.      | 300        |                  |

#### Static Electrical Characteristics

| Symbol       | Parameter   | Min  | Typ | Max       | Unit          |
|--------------|---|------|-----|-----------|---------------|
| $BV_{DSS}$   | Drain-Source Breakdown Voltage ( $V_{GS} = 0V, I_D = 250 \mu\text{A}$ )                   | 1000 |     |           | V             |
| $R_{DS(ON)}$ | Drain-Source On-State Resistance <sup>1</sup> ( $V_{GS} = 10V, I_D = 6.5A$ )              |      |     | 1.0       | ohms          |
| $I_{DSS}$    | Zero Gate Voltage Drain Current ( $V_{DS} = 1000V, V_{GS} = 0V$ )                         |      |     | 25        | $\mu\text{A}$ |
|              | Zero Gate Voltage Drain Current ( $V_{DS} = 800V, V_{GS} = 0V, T_c = 125^\circ\text{C}$ ) |      |     | 250       |               |
| $I_{GSS}$    | Gate-Source Leakage Current ( $V_{DS} = \pm 30V, V_{GS} = 0V$ )                           |      |     | $\pm 100$ | nA            |
| $g_{fs}$     | Forward Transconductance ( $V_{DS} = 25V, I_D = 6.5A$ )                                   | 3.3  | 7   | 9         | mhos          |
| $V_{GS(TH)}$ | Gate Threshold Voltage ( $V_{DS} = V_{GS}, I_D = 1mA$ )                                   | 2    |     | 4         | Volts         |

#### Thermal Characteristics

| Symbol           | Parameter   | Min | Typ | Max  | Unit               |
|------------------|---|-----|-----|------|--------------------|
| $R_{\theta JC}$  | Junction to Case  |     |     | 0.13 | $^\circ\text{C/W}$ |
| $R_{\theta JHS}$ | Junction to Sink (High Efficiency Thermal Joint Compound and Planar Heat Sink Surface.) |     |     | 0.27 |                    |

 **CAUTION:** These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

## DYNAMIC CHARACTERISTICS

ARF466FL(G)

| Symbol       | Characteristic               | Test Conditions   | MIN | TYP  | MAX | UNIT |
|--------------|------------------------------|---|-----|------|-----|------|
| $C_{iss}$    | Input Capacitance            | $V_{GS} = 0V$<br>$V_{DS} = 150V$<br>$f = 1\text{ MHz}$                                |     | 2000 |     | pF   |
| $C_{oss}$    | Output Capacitance           |   |     | 165  |     |      |
| $C_{rss}$    | Reverse Transfer Capacitance |   |     | 75   |     |      |
| $t_{d(on)}$  | Turn-on Delay Time           | $V_{GS} = 15V$<br>$V_{DD} = 500\text{ V}$<br>$I_D = 13A @ 25^\circ C$<br>$R_G = 1.6W$ |     | 12   |     | ns   |
| $t_r$        | Rise Time                    |   |     | 10   |     |      |
| $t_{d(off)}$ | Turn-off Delay Time          |   |     | 43   |     |      |
| $t_f$        | Fall Time                    |   |     | 10   |     |      |

## FUNCTIONAL CHARACTERISTICS

| Symbol   | Characteristic                     | Test Conditions                 | MIN                            | TYP | MAX | UNIT |
|----------|------------------------------------|---------------------------------|--------------------------------|-----|-----|------|
| $G_{PS}$ | Common Source Amplifier Power Gain | $f = 40.68\text{ MHz}$          | 14                             | 16  |     | dB   |
| $h$      | Drain Efficiency                   | $V_{GS} = 2.5V$ $V_{DD} = 150V$ | 70                             | 75  |     | %    |
| $\gamma$ | Electrical Ruggedness VSWR 10:1    | $P_{out} = 300W$                | No Degradation in Output Power |     |     |      |

① Pulse Test: Pulse width < 380 $\mu$ S, Duty Cycle < 2%

Microsemi reserves the right to change, without notice, the specifications and information contained herein.

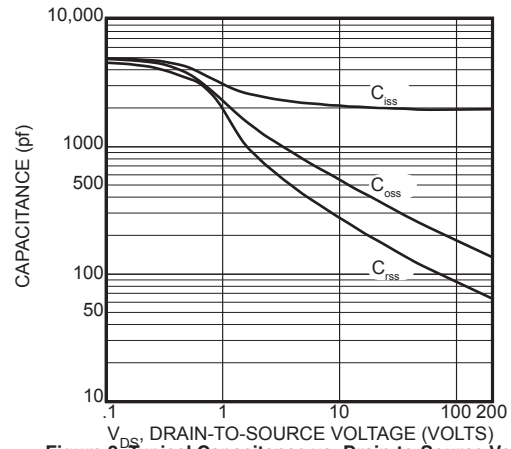


Figure 2, Typical Capacitance vs. Drain-to-Source Voltage

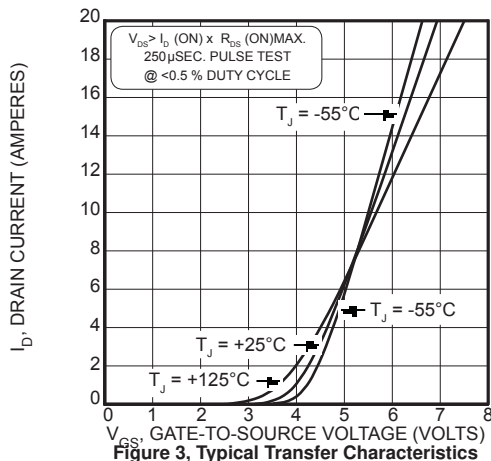


Figure 3, Typical Transfer Characteristics

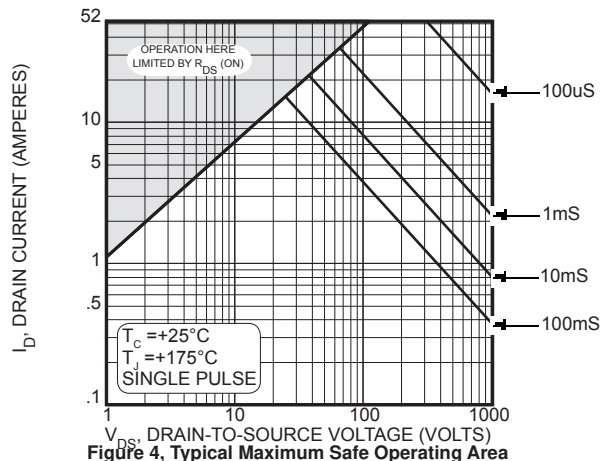


Figure 4, Typical Maximum Safe Operating Area

**TYPICAL PERFORMANCE CURVES**

ARF466FL(G)

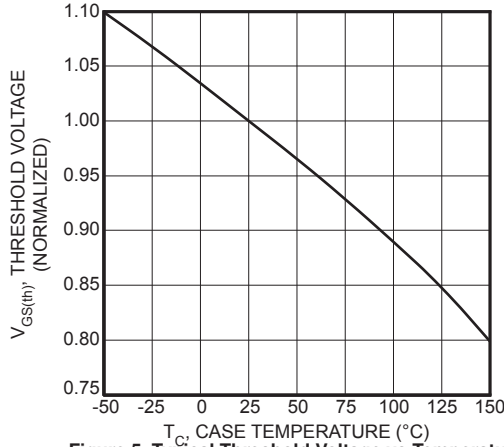


Figure 5, Typical Threshold Voltage vs Temperature

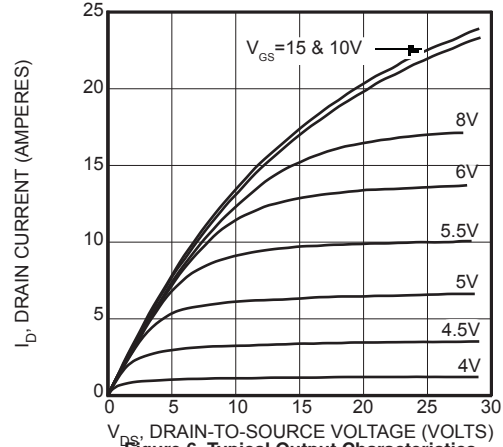


Figure 6, Typical Output Characteristics

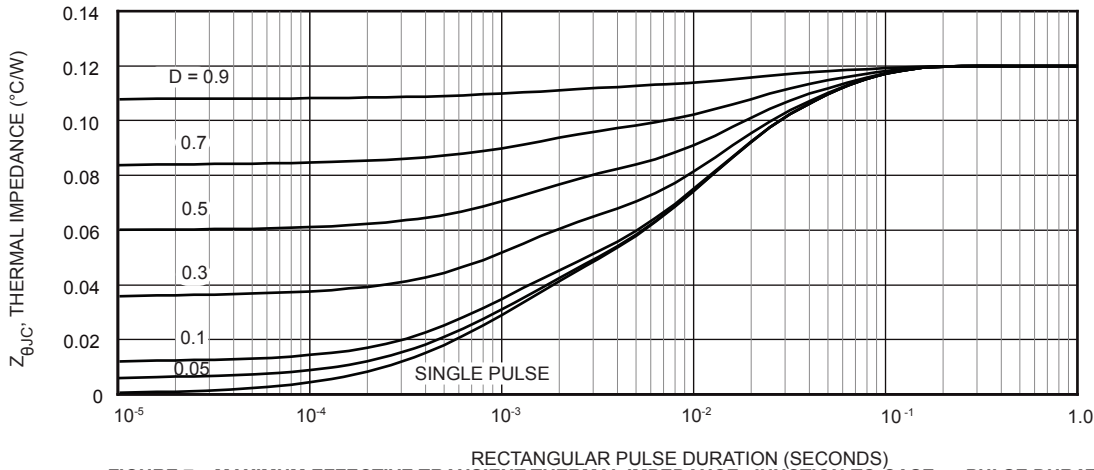


FIGURE 7a, MAXIMUM EFFECTIVE TRANSIENT THERMAL IMPEDANCE, JUNCTION-TO-CASE vs PULSE DURATION

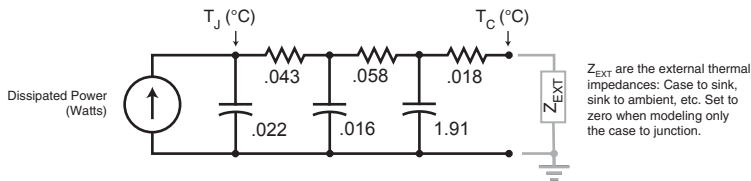


Figure 7b, TRANSIENT THERMAL IMPEDANCE MODEL

Table 1 - Typical Class AB Large Signal Input - Output Impedance

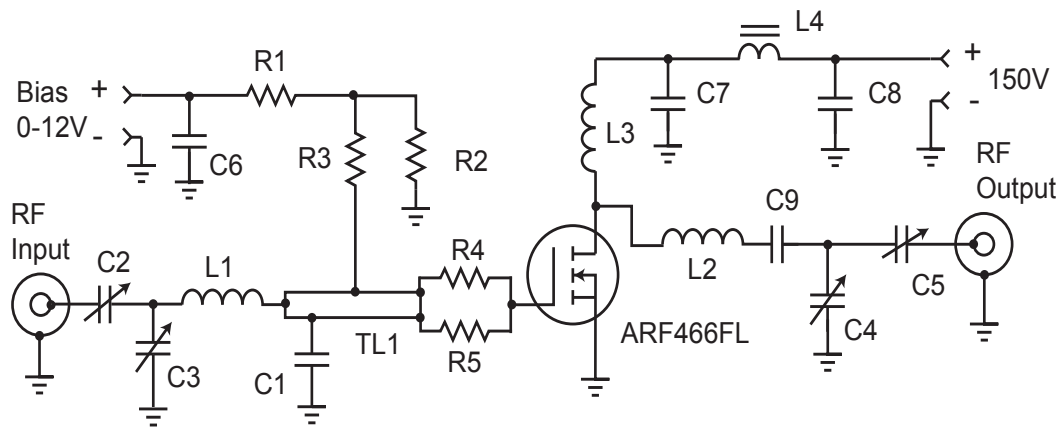
| Freq. (MHz) | Z <sub>IN</sub> (Ω) | Z <sub>OL</sub> (Ω) |
|-------------|---------------------|---------------------|
| 2.0         | 18 - j 11           | 30 - j 1.7          |
| 13.5        | 1.3 - j 5           | 25.7 - j 9.8        |
| 27.1        | .40 - j 2.6         | 18 - j 13.3         |
| 40.7        | .20 - j 1.6         | 12 - j 12.6         |
| 65          | .11 + j 0.6         | 6.2 - j 8.9         |

Z<sub>in</sub> - Gate shunted with 25Ω

I<sub>DQ</sub> = 100mA

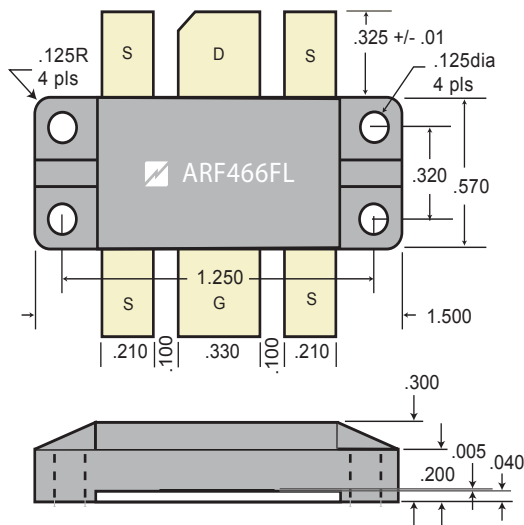
Z<sub>OL</sub> - Conjugate of optimum load for 300 W output at V<sub>dd</sub> = 150V

## 40.68 MHz Test Circuit



|                                  |  |                                     |
|----------------------------------|--|-------------------------------------|
| C1 -- 2200 pF ATC 700B           | L1 -- 3t #22 AWG .25"ID .25 "L ~55nH   | R1- R3 -- 1k $\Omega$ 0.5W          |
| C2-C5 -- Arco 465 Mica trimmer   | L2 -- 5t #16 AWG .312" ID .35"L ~176nH | R4- R5 -- 1 $\Omega$ 1W SMT         |
| C6-C8 -- .1 mF 500V ceramic chip | L3 -- 10t #24 AWG .25"ID ~.5uH         | TL1 -- 40 $\Omega$ t-line 0.15 x 2" |
| C9 -- 3x 2200 pF 500V chips COG  | L4 -- VK200-4B ferrite choke 3uH       | C1 is ~1.75" from R4-5.             |

## T3 Package Outline



## Thermal Considerations and Package Mounting:

The rated power dissipation is only available when the package mounting surface is at 25°C and the junction temperature is 175°C. The thermal resistance between junctions and case mounting surface is 0.13 °C/W. When installed, an additional thermal impedance of 0.17°C/W between the package base and the mounting surface is typical. Insure that the mounting surface is smooth and flat. Thermal joint compound must be used to reduce the effects of small surface irregularities. Use the minimum amount necessary to coat the surface. The heatsink should incorporate a copper heat spreader to obtain best results.

The package design clamps the ceramic base to the heatsink. A clamped joint maintains the required mounting pressure while allowing for thermal expansion of both the base and the heat sink. Four 4-40 (M3) screws provide the required mounting force. Torque the mounting screws to T = 2.5 - 3.5 in-lb (0.28 - 0.40 N-m).

## HAZARDOUS MATERIAL WARNING

The white ceramic portion of the device between leads and mounting surface is beryllium oxide, BeO. Beryllium oxide dust is toxic when inhaled. Care must be taken during handling and mounting to avoid damage to this area. These devices must never be thrown away with general industrial or domestic waste.